

**Search Notes**

Application/Control No.

10/098,508

Examiner

Quynh H. Nguyen

Applicant(s)/Patent under  
Reexamination

WEIK ET AL.

Art Unit

2614

**SEARCHED**

Class	Subclass	Date	Examiner
379	111 203.01 214.01 218.02 265.01	2/20/07	QN
above	updated	7/31/2007	QN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched: East, USPGPub,USPAT	2/20/07	QN
Inventor searched through PALM database	2/20/07	QN